## Notice of References Cited Application/Control No. 10/540,651 Examiner Eric S. McCall Applicant(s)/Patent Under Reexamination SCHNAIBEL ET AL. Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2007/0119242	05-2007	Buck et al.	073/118.1
*	В	US-2005/0145233	07-2005	Schneider et al.	123/690
*	С	US-2003/0014967	01-2003	Daetz et al.	60/285
*	D	US-6,550,307	04-2003	Zhang et al.	73/23.32
*	Е	US-6,439,038	08-2002	Rosel et al.	73/117.3
*	F	US-6,167,754	01-2001	Koenders, Johannes	73/116
*	G	US-5,317,868	06-1994	Blischke et al.	60/274
	Н	US-			
	1	US-			
	J	US-			•
	K	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

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## **NON-PATENT DOCUMENTS**

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